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Application Number

		Application Number	10/549,40	1					
TRANSMITTAL		Filing Date	September	r 13, 2005					
FORM		First Named Inventor	Brian J. Da	aniels					
		Art Unit	Unknown						
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Amendment/Reply		Petition As Comment to			Appeal Communication to TC (Appeal Notice, Brief, Reply Brief)				
After Final		Petition to Convert to a Provisional Application		Propr	etary Information				
Affidavits/declaration(s)		Power of Attorney, Revocat Change of Correspondence		Statu	s Letter				
Extension of Time Request		Terminal Disclaimer		Other below	Enclosure(s) (please Identify				
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Firm Name Wells St. John P.S.									
Signature	97	Taylor							
Printed name Jennifer J. Taylor, Ph									
Date June 12, 2006	,		Reg. No.	48,711					
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This collection of information is required by 37 CFR 1.5. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.11 and 1.14. This collection is estimated to 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

If you need assistance in completing the form, call 1-800-PTO-9199 and select option 2.

Inventor:

Brian J. Daniels et al.

Title:

Copper-Containing PVD Targets and Methods for Their Manufacture

Assignee: Honeywell International Inc.

INFORMATION DISCLOSURE STATEMENT

References - See Attached Form PTO-1449

The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. No admission is made regarding whether any of the submitted references is prior art. Copies of the references are attached.

Respectfully submitted,

Form PTO-1449 U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. SERIAL NO. PATENT AND TRADEMARK OFFICE H0006041.70974 US 10/549,401 **APPLICANT** LIST OF ART CITED BY APPLICANT (Use several sheets if necessary) Brian J. Daniels et al. FILING DATE **GROUP** September 13, 2005 Unknown U.S. PATENT DOCUMENTS *Examiner Document Date Name Class Sub-Filing Date class Initial Number If Appropriate AA 3,963,934 06-1976 Ormrod AB 4,132,614 01-1979 Cuomo et al. 04-1979 AC 4,149,907 Wronski et al. AD 07-1979 Wilson 4,159,909 ΑE 4,198,283 04-1980 Class et al. AF 4,209,375 06-1980 Gates et al. AG 4,385,979 05-1983 Pierce et al. AΗ 4,545,882 10-1985 McKelvey 4,629,859 12-1986 Reddy FOREIGN PATENT DOCUMENTS Document Date Class Translation Sub-Country Number class Yes No AM 0335383 A2 10-1989 **EPO** ΑN 0626722 A1 11-1994 **EPO** AO 85104006 A 10-1986 CN OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) ÁR Lucke, K. et al., "Physical Metallurgy Principles" 2nd ed., 1973, p. 298. Phillips, V.A. et al., "The Effect of Certain Solute Elements on the AS Recrystallization of Copper", Journ. of Institute of Metals, Vol. 81, 1952-53, pp. 185-208. AΤ Brizzolara et al., "Low Energy Sputtering of Eutectic Ag/Cu Alloys", Nuclear Instruments and Methods in Physics Research B26, 1987, pp. 528-531. **EXAMINER** DATE CONSIDERED *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not

in conformance and not considered. Include copy of this form with next communication to applicant.

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Yes	No
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